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(54) **Polyvinyl alcohol base photosensitive resin, photosensitive composition, and method for pattern formation using the same**

(57) This invention is aimed at providing a photosensitive resin, a photosensitive resin composition, and a method for pattern-formation by which the excellent properties of water-resistance and heat-resistance, and sufficient water-solubility, and an excellent compatibility to an anionic additive can be attained. According to the invention, a photosensitive resin is provided as a polyvinyl alcohol base polymer compound obtained by suspending a styryl compound (I) having a nitrogen heterocyclic ring with a quaternary aromatic species and a phenyl compound (II) having two sulfone groups, in which the content of (I) is 0.5 to 10 mole % while the content of (II) is 0.1 to 20 mole %.

Description

BACKGROUND OF THE INVENTION

FIELD OF THE INVENTION

The present invention relates to a polyvinyl alcohol base photosensitive resin, a photosensitive resin composition, and a method of forming a pattern using the resin or the composition. More specifically, the present invention relates to a photosensitive resin, a photosensitive resin composition, and a method of forming a pattern using the resin or the composition, allowing a favorable pattern formation on an anionic substrate as a consequence of its excellent mutual solubility with an anionic additive.

DESCRIPTION OF THE PRIOR ART

As water-soluble polyvinyl alcohol base photosensitive resins, heretofore, polyvinyl alcohol base photosensitive resins described in patent documents such as Japanese Patent Application Publication No. 56-5761, Japanese Patent Application Publication No. 56-5762, Japanese Patent Application Laying-open No. 56-11906, Japanese Patent Application Laying-open No. 59-17550, Japanese Patent Application Laying-open 2-118575, Japanese Patent Application Laying-Open No. 2-276806, and Japanese Patent Application Publication No. 6-43645 have been known, in which each of them comprises a styryl derivative as a pendant group having a nitrogen heterocyclic ring with a quaternary aromatic species. However, these resins have the following disadvantages. That is, these photosensitive resins show high photosensitivities but poor water-resisting properties. Therefore they can be swelled at the stage of development, resulting in an insufficient resolution. In addition, these photosensitive resins are cationic materials, so that each of them tends to become thicker or to become a gel when they are mixed with an anionic additive such as an anionic surfactant and an emulsion. Furthermore, when a pattern is formed on an anionic surface of the substrate using the above photosensitive resin, scum can be generated as a result of ionic interaction.

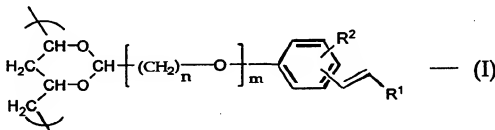
For solving the above disadvantages, on the other hand, there is disclosed a polyvinyl alcohol having a styryl derivative as a pendant group having a nitrogen heterocyclic ring with a quaternary aromatic species having betaine structure as a polyvinyl alcohol base photosensitive resin in Japanese Patent Application Laying-open No. 2-160807. In this case, however, the photosensitive resin has several disadvantages including an insufficient water-solubility and a slightly lowered sensitivity.

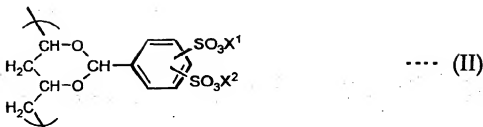
Accordingly, all of the conventional polyvinyl alcohol base photosensitive resins described above have several disadvantages including poor water-resisting properties, poor thermal-resisting properties, and poor compatible properties with anionic additives.

With a view to the above disadvantages, therefore, the object of the present invention is to provide a photosensitive resin having the excellent properties of water-resistance and thermal-resistance, sufficient water-solubility, and sufficient compatibility with an anionic additive, together with a photosensitive resin composition and a method of pattern formation using the novel resin or composition.

SUMMARY OF THE INVENTION

The first aspect of the present invention for solving the above problems is a polyvinyl alcohol base photosensitive resin characterized by comprising a polyvinyl alcohol base polymer compound having structural units of the following general formula (I) and (II):





(wherein each of X¹ and X² denotes a hydrogen atom, a sodium ion, a potassium ion, or an ammonium ion), wherein the content of the structural unit of the general formula (I) is 0.5 to 10 mole %, while the content of the structural unit of the general formula (II) is 0.1 to 20 mole %.

15 Preferably, the mole ratio represented by the structural unit of the general formula (I)/the structural unit of the general formula (II) may be less than 2.

The second aspect of the present invention is a polyvinyl alcohol base photosensitive resin composition characterized by comprising the above polyvinyl base photosensitive resin.

20 Preferably, the mole ratio represented by the structural unit of the general formula (I)/the structural unit of the general formula (II) in the above polyvinyl alcohol base photosensitive resin may be less than 2.

Preferably, the photosensitive resin composition of the present invention may further comprise an anionic additive.

25 The third aspect of the present invention is a method of forming a pattern, characterized by comprising the steps of: forming a photosensitive resin layer on a substrate by applying the above polyvinyl alcohol base photosensitive resin composition of the present invention; and performing a pattern exposure on said photosensitive resin layer and a subsequent development.

The present inventors have assiduously studied in order to develop a photosensitive resin having excellent properties enough to solve the above problems. As a consequence, the inventors have found that a polyvinyl alcohol base polymer compound obtained by suspending a styryl compound having a nitrogen heterocyclic ring with a quaternary aromatic species and a phenyl compound having two sulfone groups at a predetermined mole ratio attains the above object, resulting in the present invention.

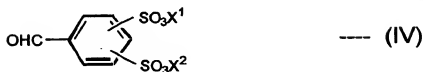
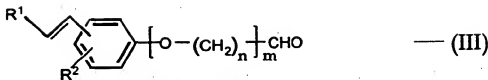
A polyvinyl alcohol base photosensitive resin is a novel one that shows good water-resistance and high-sensitivity.

30 In addition, especially, the one in which the mole ratio represented by the structural unit of the general formula (I)/the structural unit of the general formula (II) is less than 2 shows good compatibility with an anionic additive, and hence it can be used for forming a pattern on an anionic substrate.

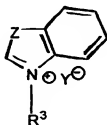
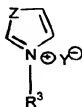
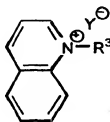
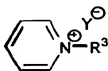
35 The above and other objects, effects, features, and advantages of the present invention will become more apparent from the following description of embodiments.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

40 A polyvinyl alcohol base polymer compound to be comprised in a photosensitive resin of the present invention can be easily prepared by reacting saponified poly(vinyl acetate) or saponified copolymer of vinyl acetate with the other vinyl compound with an aldehyde or an acetal represented by the following general formula (III) and an aldehyde represented by the following general formula (IV) in an aqueous solvent in the presence of an acidic catalyst.



20 In the above general formula (III), R¹ denotes a nitrogen heterocyclic ring containing a quaternized aromatic series and it can be exemplified by the following formulas.



45 In the above formulas, R³ denotes a lower alkoxyl group, a lower alkoxyl carbonyl alkyl group, or a benzyl group; Y⁻ denotes an anion ion such as a chloride ion, a bromide ion, an iodide ion, a mono-alkyl sulfonate ion, or a p-toluene sulfonate ion; and Z denotes O, S, Se, or NR⁴ (R⁴ is a lower alkyl group).

50 Acidic catalysts to be utilized in a reaction for preparing a polyvinylalcohol base polymeric compound as photosensitive resin of the present invention include phosphoric acid, hydrochloric acid, sulfuric acid, p-toluenesulfonic acid, metasulfonic acid, and a resin used for an acidic ion-exchange resin. It is noted that the acidic catalyst may be a compound represented by the general formula (IV) where X¹ and X² are hydrogens, or either X¹ or X² is a hydrogen.

The above reaction can be conducted in an aqueous solvent, preferably in water. There is no restraint on the reaction condition. In general, however, the reaction may be performed at about 20-100 °C for 2-72 hours.

55 After terminating the reaction, a reaction mixture is poured into an abundance of poor solvent such as acetone, ethanol, or dioxane to form a precipitate of a desired resin. Then the resin is separated from the reaction mixture and then washed and dried to obtain a photosensitive resin of the present invention. After terminating the reaction, alternatively, the reaction mixture is neutralized using an alkaline aqueous solution such as an aqueous sodium hydroxide, an aqueous potassium hydroxide, or an aqueous ammonia water, or using a basic ion-exchange resin, followed by a filtration of the ion-exchange resin. Consequently, an aqueous solution of a desired photosensitive resin can be obtained.

Saponified poly(vinyl acetate)s to be used in the above reaction may be of, for example, ranging in an average degree of polymerization from 200 to 5,000, preferably from 300 to 3,000, and also ranging in a degree of saponification from 60 to 100 %, preferably from 70 to 99 %.

The reason why the average degree of polymerization should be kept in the range of 200 to 5,000 is that a sufficient sensitivity cannot be obtained when it is less than 200, and a viscosity of the solution of photosensitive composition becomes too high when it is higher than 5,000, resulting in poor applicability of the solution or lower water-developability. In any of these instances, therefore, undesired results may be caused.

Furthermore, the reason why the degree of saponification should be in the range of 60 % to 100 % is that a sufficient water-solubility and a sufficient water-developability cannot be obtained when it is less than 60 %.

Instead of saponified poly(vinyl acetate), as described above, it is possible to use a saponified copolymer of vinyl acetate with one of the other vinyl compounds including N-vinyl pyrrolidone, acrylamide, and N,N-dimethyl acrylamide.

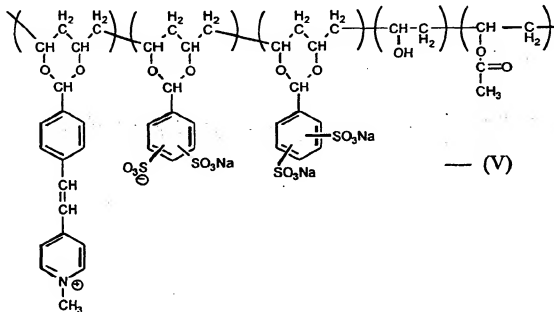
In the case of performing the reaction among this kind of saponified poly(vinyl acetate), the compound of the above general formula (III) and/or an acetal thereof, and the compound of the above general formula (IV) in the preference of an acidic catalyst, it is possible to react them together with one of the aldehydes such as formaldehyde, acetaldehyde, propionaldehyde, butylaldehyde, benzaldehyde, hydroxybenzaldehyde, and acetals thereof.

The introduction rate of the compound of the general formula (III) or the acetal thereof to the saponified poly(vinyl acetate) is 0.5 to 10 mole %, preferably 0.8 to 7 mole % per mole unit. This is because if it is less than 0.5 mole % the sensitivity is lowered without practicality while if it is more than 10 mole % the water-solubility is not enough. For attaining a high sensitivity, the rate of introduction should be increased when the degree of polymerization of the saponified poly(vinyl acetate) is low, while if the degree of polymerization is high a sufficient sensitivity can be attained even though the introduction rate is low.

The introduction rate of the compound of the general formula (IV) to the saponified poly(vinyl acetate) is 0.1 to 20 mole %, preferably 0.3 to 15 mole % per mole unit. This is because if it is out of that range the water resistibility tends to be deteriorated.

For the photosensitive resin of the present invention, it is preferable that a mole ratio represented by a constituent unit of the general formula (I) / a constituent unit of the general formula (II) is less than 2. In this case, the resin tends to be an anionic one having the properties of good compatibility with anionic additives and avoiding a generation of scum in the step of forming a pattern of an anionic substrate, in addition to the properties of high-sensitivity and good water-resistance.

As will be described in the description concerning the third example of the synthesis thereof, inner and/or intermolecular salts may be formed in the poly(vinyl alcohol) base photosensitive resin because of no detection of phosphate ions and methyl sulfate ions under the assaying of anionic ions of the obtained resin using an ion chromatography. In Synthesis Example 3, for example, the resin has a structure represented by the following general formula (V).



The photosensitive resin composition of the present invention comprises the above described photosensitive resin of the present invention. In particular, the resin shows good compatibility with anionic additives when the mole ratio represented by a structural unit of the general formula (I)/a structural unit of the general formula (II) is less than 2, so that the composition may comprise an additional anionic additive.

Among anionic hydrophobic polymer emulsions, the following emulsions (1), (2), and (3) can be used as the above additional anionic additive.

(1) A hydrophobic polymer emulsion comprising an anionic surfactant as an emulsifying agent, in which the anionic surfactant may be, for example higher fatty acid salt, higher alkyl dicarboxylic acid salt, sulfated higher alcohol, alkyl sulfonic acid salt, higher alkyl disulfonic acid salt, sulfated oil or fatty acid salt, sulfonated higher fatty acid salt, higher alkyl phosphate, sulfate or sulfonate of higher fatty acid, sulfate or sulfonate of higher alcohol ether, condensate of higher fatty acid and amino acid, alkylated sulfate of higher fatty amide, alkylated sulfonate of higher fatty amide, alkyl carboxylate of sulfonamide, ester of sulfosuccinic acid, alkyl benzenesulfonic acid salt, alkyl phenolsulfonic acid salt, alkyl naphthalene sulfonic acid salt, formaline condensate of alkyl naphthalene sulfonic acid salt, alkyl tetralin sulfonic acid salt, alkyl benzimidazole sulfonic acid salt, naphthenic acid salt, or naphthenic alcohol sulfate.

(2) A hydrophobic polymer emulsion comprising an anionic protective colloid as an emulsion, in which the anionic protective colloid may be, for example, carboxyl or sulfonate denatured polyvinyl alcohol, poly(acrylic acid salt), or poly(methacrylic acid salt).

(3) A hydrophobic polymer emulsion comprising an unsaturated compound as a copolymerized component, in which the unsaturated compound may be, for example, acrylic acid, methacrylic acid, itaconic acid, or 2-sulfoethyl methacrylate.

Anionic surfactants include the same chemicals as in the description concerning the anionic hydrophobic polymer emulsion.

Anionic dye stuffs include a substantive dye and an acidic dye.

Anionic pigments include a pigment having a carboxylic group or a sulfonic group, and a pigment treated with an anionic polymer or the like.

Anionic water-soluble polymers include a water-soluble polymer having a carboxyl group or a sulfonic group.

One of the advantages of the present composition is that it can be used in conjunction with the other anionic photosensitive materials such as 4,4'-diazide stilbene-2,2'-disulfonic acid, 4,4'-diazide benzalacetone-2,2'-disulfonic acid, 2,5-bis (4'-azide-2'-sulfo benzylidene) cyclopentanone, 2,6-bis (4'-azide-2'-sulfo benzylidene) cyclohexane, or one of their alkali metal salts, ammonium salts, organic amine salts, and organic quaternary ammonium salts.

For containing the above anionic azide base photosensitive material into the composition of the present invention, it is preferable to further provide a water-soluble polymer having a good reactivity with a photoreactive intermediate of the azide group into the composition. The water-soluble polymer may be poly(vinyl pyrrolidone), poly(acrylamide), poly (N,N-dimethyl acrylamide), copolymer of acrylamide with diacetone acrylamide, copolymer of acrylamide with N,N-dimethylacrylamide, and cationic cellulose.

Characteristics of the present composition can be further improved by adding at least a photopolymerizable unsaturated compound and a photopolymerization initiating system.

The photopolymerizable an unsaturated compound may be either hydrophobic or hydrophilic, for example an unsaturated prepolymer or an unsaturated polymer comprising at least one polymerizable unsaturated group having an acryl group, a methacryl group, an aryl group, a vinyl ether group, a vinyl group, an acrylamide group, or the like.

The photopolymerization initiating system may be a system responsible for generating free radicals having photopolymerizing activities by irradiating light, for example an α -bond cleavage type initiator such as benzoin ether, hydroxyl alkyl ketone, dialkoxyacetophenone, benzoyl phosphine oxide, or benzoin oxime ketone; aromatic ketone such as benzophenone, benzyl, thioxanthone, or keto-coumarin; a system of the aromatic ketone and a hydrogen donor such as amine; a system of organic peroxide, onium salt, triphenyl alkyl borate, or an iron/arene complex, and an electron donor such as thioxanthene dye, or keto-coumarin; a system of N-aryl glycine and an electron acceptor; and polyhalide compound.

In general, furthermore, it is preferable that a heat polymerization inhibitor is added in those photopolymerization systems.

The composition of the present invention may further comprise a non-ionic hydrophobic polymer emulsion, a surfactant, a dye, a pigment, an inorganic filler, an emulsion stabilizer, a plasticizer, a leveling agent, and so on, excepting any one of the above components. A cationic additive may be also comprised in the above composition with an acceptable amount thereof without thickening or gelling a solution of the composition. The composition may further comprise any of the phosphors for forming a phosphor pattern or any of the light absorption materials such as graphite for forming a black matrix.

The composition of the present invention may be prepared by adding the above cationic additive and the other var-

ious additives as needed into the above polyvinyl alcohol base polymer compound and dissolving or dispersing the mixture in a water base solvent.

In this case, water may be generally used as the solvent. However, it is possible to add a water-soluble solvent into the water at the concentration of less than 50 wt. %. The water-soluble solvent may be a water-soluble agent such as methyl alcohol, ethyl alcohol, isopropyl alcohol, acetone, tetrahydrofuran, dioxan, dimethyl formamide, or N-methyl pyrrolidinone, ethylene glycol monomethyl ether, ethylene glycol monoethyl ether, or the like.

The photosensitive resin composition of the present invention obtained by the way as described above may be coated and dried on a substrate so as to obtain a coating film with a dry thickness of 0.5 to 1,000 μm , for example. The substrate may be selected from a metal plate made of aluminum, stainless steel, or the like, a screen mesh, a sheet of paper, a glass plate, a semiconductor substrate, and so on, with reference to the uses.

A patterning image can be formed on the coating film by the steps of irradiating the coating film with ultra-violet, for example an active beam of 300 to 500 nm in wavelength to cure an irradiated portion of the coating film and removing a non-irradiated portion of the coating film using water or the like. Therefore, it can be used as a screen printing plate, a black matrix or a phosphor pattern formation of a color cathode-ray tube (CRT), a color filter of CCD or LCD, a color printing proof, any one of various kinds of etching resists, or the like.

A pattern formation particularly suited for using the composition of the present invention is to form a pattern on a substrate having an anionic surface. The pattern with the remaining scum on the non-irradiated portion can be obtained when the pattern is formed on the substrate having the anionic surface using the conventional cationic polyvinyl alcohol base photosensitive resin. On the other hand, a clean pattern without any scum can be obtained when the pattern is formed on the substrate using the composition of the present invention.

Then concrete examples of the pattern formation on the substrate having the anionic surface using the present composition will be described in detail. A color CRT comprises strips or dot patterns of red, green, and blue phosphors and non-luminescent light-absorbing materials such as graphite that fills spaces among the phosphors, in which the latter is designated as a black matrix. It can be prepared by the following steps. At first, each color phosphor pattern is formed after forming the black matrix which is provided as a graphite-dispersed liquid. A dispersant to be used in the step of dispersing the graphite is selected from anionic chemicals such as a sodium salt of carboxymethyl cellulose (Japanese Patent Application Laying-open No. 46-218), a lithium salt of carboxymethyl cellulose (Japanese Patent Application Laying-open No. 4-82140), and sodium β -naphthalene sulfonate. Consequently, the surface of the black matrix is provided as an anionic one on which a photosensitive composition comprising dispersed phosphors is applied and then developed after light exposure. If the photosensitive composition is cationic, the development cannot be performed perfectly and scum remains on the surface. It results in the remaining phosphor on the black matrix at the non-illuminating portion. Using the anionic composition of the present invention in the photosensitive composition comprising the dispersed phosphors, on the other hand, a clean pattern of each phosphor without any color mixtures can be obtained as a result of the perfect development.

(Synthesis Example 1)

Polyvinyl alcohol (PVA) GH-17 (manufactured by Nippon Synthetic Chemical Industry, the degree of polymerization of 1,700 and the degree of saponification of 88 %) in an amount of 10 g was dissolved in 90 g of pure water. Then 0.581 g of N-methyl-4-formylstyryl pyridinium methanesulfate (hereinafter abbreviated as SbQ; the ratio to a unit mole of PVA was 0.85 mole %) and 0.25 g of phosphoric acid were added in the dissolved solution and stirred at 30 °C for 3 hours. Furthermore, 0.783 g of sodium benzaldehyde-2,4-disulfonate (hereinafter abbreviated as diBAS; purity = 84.7 %; concentration = 1.235-fold mole of SbQ) was added and stirred at 30 °C for 20 hours to obtain a reaction mixture. In the reaction mixture, 2.5 g of Amberlite IR-45 (ion-exchange resin manufactured by Rohm & Haas) was added and then stirred for 2 hours. After completion of the reaction, the pH of the mixture was checked to be neutral and then the mixture was filtered through 400-mesh screen to obtain a light-yellowish polymer aqueous solution.

Measuring with an ultraviolet spectrophotometry, introduction rates of SbQ and diBAS to polyvinyl alcohol molecules were 0.72 mole % and 0.76 mole %, respectively.

(Synthesis Example 2)

Polyvinyl alcohol (PVA) GH-17 (manufactured by Nippon Synthetic Chemical Industry, the degree of polymerization of 1,700 and the degree of saponification of 88 %) in an amount of 10 g was dissolved in 90 g of pure water. Then 0.581 g of SbQ (the ratio to a unit mole of PVA was 0.85 mole %) and 0.25g of acid were added in the dissolved solution and stirred at 30 °C for 3 hours. Subsequently, 0.286 g of diBAS (concentration = 0.54-molar equivalent of SbQ) was added and stirred at 30 °C for 20 hours to obtain a reaction mixture. In the reaction mixture, 2.5 g of Amberlite IR-45 (ion-exchange resin manufactured by Rohm & Haas) was added and then stirred for 2 hours. After completion of the reaction, the pH of the mixture was checked to be neutral and then the mixture was filtered through 400-mesh screen to obtain a light-yellowish polymer aqueous solution.

Measuring with an ultraviolet spectrophotometry, the introduction rates of SbQ and IBAS to polyvinyl alcohol molecules were 0.72 mole % and 0.33 mole %, respectively.

(Synthesis Example 3)

Polyvinylalcohol (PVA) GH-17 (manufactured by Nippon Synthetic Chemical Industry, the degree of polymerization of 1,700 and the degree of saponification of 88 %) in an amount of 10 g was dissolved in 90 g of pure water. Then 0.581 g of SbQ (the ratio to a unit mole of PVA was 0.85 mole %) and 0.25 g of phosphoric acid were added in the dissolved solution and stirred at 30 °C for 3 hours. Subsequently, 0.783 g of diBAS (concentration = 1.235-molar equivalent of SbQ) was added and stirred at 30 °C for 20 hours to obtain a reaction mixture. An excess amount of acetone was poured into the reaction mixture to obtain a white polymer precipitate. The precipitate was washed with methanol sufficiently and then dried in a vacuum, resulting in 9.5 g of polyvinyl alcohol derivative.

Measuring with an ultraviolet spectrophotometry, the introduction rates of SbQ and IBAS to polyvinyl alcohol molecules were 0.72 mole % and 0.76 mole %, respectively.

In addition, methyl sulfate ions derived from SbQ and phosphate ions derived from the catalyst were detected in extremely small quantities by ion-chromatographic analysis. Consequently, the results give support to the internal salt structure represented by the general formula (V), so that it reveals that the polymer is anionic one.

(Synthesis Comparative Example 1)

A polyvinyl alcohol derivative comprising the above PVA (GH-17) reacted with 0.72 mole % of SbQ was obtained according to the process disclosed in Japanese Patent Laying-open No. 55-23163. There was no anionic composition in the product, so that it was a perfect cationic polymer.

(Example 1)

10 wt. % of the polymer aqueous solution of Synthesis Example (I) was mixed with Finetex ES-650 (manufactured by Dai Nippon Ink, Co., Ltd.; polyester emulsion, a dry solids content of 29 wt. %) at a solids ratio of one to two. A clear photosensitive composition was obtained except for an extremely small amount of thickening.

Then the above photosensitive composition was applied on a 250-mesh screen printing plate through a screen to make a coating film of 15 μ m in thickness. Subsequently, the coating film was developed with a water-spray. The coating film was exposed for 90 seconds by means of an extra-high pressure mercury-vapor lamp (2kw) positioned at a distance of 60 cm from the surface of the film. Making visual observations, there was no substantial swelling in the resulting film. In addition, a good resolution was attained.

(Synthesis Comparative Example 2)

10 wt. % of an aqueous solution was prepared by dissolving the polymer obtained in Comparative Example 1 as is the case with Example 1. Using the same procedure as that of Example 1, the aqueous solution was mixed with ES-200 at a solids ratio of 1 to 2, resulting in extremely high thickening. Consequently, the same test on the screen as that of Example 1 could not be performed.

(Example 2)

10 wt. % of the polymer aqueous solution of Synthesis Example (II) was mixed with a vinyl acetate emulsion (Mowinyl MA6 manufactured by Hoechst Synthesis, Co., Ltd.) at a solids ratio of one to two. Then the mixture was applied on a 250-mesh screen printing plate through a screen to make a coating film of 15 μ m in thickness. Subsequently, the coating film was developed with a water-spray. The coating film was exposed for 110 seconds by means of an extra-high pressure mercury-vapor lamp (2kw) positioned at a distance of 60 cm from a surface of the film. According to visual observations, therefore, there was no substantial swelling in the resulting pattern. In addition, a good resolution was attained.

(Comparative Example 2)

10 wt. % of the polymer aqueous solution of Synthesis Comparative Example (II) was mixed with a vinyl acetate emulsion (Mowinyl MA6 manufactured by Hoechst Synthesis, Co., Ltd.) at a solids ratio of one to two. Then the mixture was applied on a 250-mesh screen printing plate through a screen to make a coating film of 15 μ m in thickness. Subsequently, the coating film was developed with a water-spray. The coating film was exposed for 110 seconds by means of an extra-high pressure mercury-vapor lamp (2kw) positioned at a distance of 60 cm from the surface of the film. Com-

paring with the results of Example 2, there was observed a larger amount of swelling in the resulting pattern. In addition, a poor resolution was obtained.

(Example 3)

A photosensitive solution consisting of polyvinylpyrrolidone and 4,4'-diazidestilbene-2,2'-sodium disulfonate, Elettrodruk 1530 (manufactured by Achison Japan, Co., Ltd.; a graphite fluid dispersion), and a shadow mask with a hole size of 135 μm were used according to the general process disclosed in Japanese Patent Laying-open No. 48-90815 and so on. As a result, the black matrix of the CRT with a hole size of 105 μm was prepared on a soda glass plate of 10 cm square.

Then a so-called phosphor slurry of the following formula was applied on the above glass plate and then dried to make the film with 8 to 10 μm in thickness. Subsequently, a phosphor pattern was prepared according to the following conditions. According to the observations on the resulting pattern, the packing density of the phosphor was excellent. In addition, an excellent resolution was also observed and the remaining phosphor was not detected on the black matrix.

(Composition of Phosphor Slurry)

Green phosphor	10 gr.
10 wt.% polymer aqueous solution of Synthesis Example 1	10 gr.
Pure water	15 gr.
5 % Tamol 731 aqueous solution (manufactured by Rohm & Haas, Co., Ltd.; an anionic surfactant)	1 gr.
10 % LT-221 aqueous solution (manufactured by Nippon Oil & Fats, Co., Ltd.; a nonionic surfactant)	0.05 gr.

(Condition of Pattern Formation)

Shadow mask: a hole diameter of 135 μm
 Distance between shadow mask and glass plate: 10 mm
 Distance between light-source and glass plate: 30 cm
 light-source: Ultra-high pressure mercury lamp, an intensity of illuminance of 0.15 mW/cm² 350 nm,
 Exposure time: 40 sec.
 Development: Water-spray development

(Comparative Example 3)

In an analogous fashion, furthermore, the polymer of Comparative Example 2 was evaluated. In this example, however, a phosphor slurry was prepared from the formula of Example 3 except Tamol 731 as a surfactant because there was an insufficient compatibility between them.

A phosphor pattern was prepared under the same conditions as that of Example 3 and using the above phosphor slurry. According to the observations on the resulting pattern, the packing density of the phosphor was excellent and also an excellent resolution was observed just as in the case of Example 3. In this case, however, the remaining phosphor was not detected on the black matrix. A large amount of phosphor remained on the black matrix after the development.

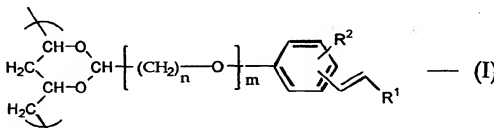
According to such results, the polymer of Comparative Example 1 is a cationic polymer and thus it tends to remain as a result of ionic interaction with an anionic surface of the black matrix. Consequently, it is presumed that the phosphor tends to remain on the surface of the black matrix.

According to the present invention, as described above, a photosensitive resin is provided as a polyvinyl alcohol base polymer compound obtained by suspending a styryl compound having a nitrogen heterocyclic ring with a quaternary aromatic species and a phenyl compound having two sulfone groups, so that it has the effects of the excellent properties of water-resistance and heat-resistance, and sufficient water-solubility. In addition, it also has the effect of excellent compatibility to an anionic additive by appropriately selecting the ratio of components.

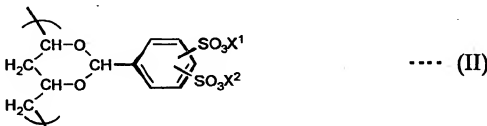
The present invention has been described in detail with respect to preferred embodiments, and it will now be that changes and modifications may be made without departing from the invention in its broader aspects, and it is the intention, therefore, in the appended claims to cover all such changes and modifications as fall within the true spirit of the invention.

Claims

1. A polyvinyl alcohol base photosensitive resin comprising a polyvinyl alcohol base polymer compound having structural units of the following general formulae (I) and (II):



(wherein R¹ denotes a residue of a heterocyclic ring having a quaternized aromatic species, R² denotes a hydrogen atom or a lower alkoxy group, m is 0 or 1, and n is an integer number selected from 1 to 6.); and



(wherein each of X¹ and X² denotes a hydrogen atom, a sodium ion, a potassium ion, or an ammonium ion.), wherein a content of said structural unit of general formula (I) is 0.5 to 10 mole %, while a content of said structural unit of general formula (II) is 0.1 to 20 mole %.

2. A polyvinyl alcohol base photosensitive resin as disclosed in Claim 1, wherein the mole ratio represented by said structural unit of general formula (I)/said structural unit of general formula (II) is less than 2.
3. A polyvinyl alcohol base photosensitive resin composition comprising a polyvinyl base photosensitive resin of Claim 1.
4. A polyvinyl alcohol base photosensitive resin composition as disclosed in Claim 3, wherein the mole ratio represented by said structural unit of general formula (I)/said structural unit of general formula (II) in said polyvinyl base photosensitive resin is less than 2.
5. A polyvinyl alcohol base photosensitive resin further comprising an anionic additive.
6. A method of forming a pattern, comprising the steps of:

forming a photosensitive resin layer on a substrate by applying a polyvinyl alcohol base photosensitive resin composition as described in any one of Claims 3 to 5; and performing a pattern exposure on said photosensitive resin layer; and subsequently developing.



European Patent
Office

EUROPEAN SEARCH REPORT

Application Number
EP 96 11 9803

DOCUMENTS CONSIDERED TO BE RELEVANT			
Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int.Cl.4)
X	EP 0 130 804 A (KOGYO GIJUTSUIN) 9 January 1985 * page 40, line 4 - line 25; examples D13-D18 * * page 42, line 1 - line 21; examples D19-D22 * ---	1-6	G03F7/038 G03F7/033 C08F8/36 G03F7/032
X	GB 2 174 997 A (DIRECTOR-GENERAL OF AGENCY OF INDUSTRIAL SCIENCE AND TECHNOLOGY) 19 November 1986 * page 1, line 5 - line 10 * * page 2, line 5 - line 57 * * page 3, line 31 - line 34 * ---	1-6	
X	DATABASE WPI Section Ch, Week 8624 Derwent Publications Ltd., London, GB; Class A89, AN 86-153154 XP002026965 & JP 61 087 153 A (AGENCY OF IND SCI TECH) , 2 May 1986 * abstract * -----	1-6	TECHNICAL FIELDS SEARCHED (Int.Cl.4) G03F C08F
The present search report has been drawn up for all claims			
Place of search THE HAGUE		Date of completion of the search 5 March 1997	Examiner J.-M. DUPART
CATEGORY OF CITED DOCUMENTS X : particularly relevant if taken alone Y : particularly relevant if combined with another document of the same category A : technological background O : non-written disclosure P : intermediate document T : theory or principle underlying the invention E : earlier patent document, but published on, or after the filing date D : document cited in the application L : document cited for other reasons & : member of the same patent family, corresponding document			

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